

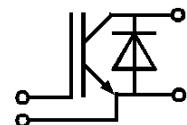
Absolute Maximum Ratings		Values	Units
Symbol	Conditions <sup>1)</sup>		
$V_{CES}$		1700	V
$V_{GCR}$	$R_{GE} = 20 \text{ k}\Omega$	1700	V
$I_c$	$T_{case} = 25/80^\circ\text{C}$	300 / 200	A
$I_{CM}$	$T_{case} = 25/80^\circ\text{C}; t_p = 1 \text{ ms}$	600 / 400	A
$V_{GES}$		$\pm 20$	V
$P_{tot}$	per IGBT, $T_{case} = 25^\circ\text{C}$	1750	W
$T_j, (T_{stg})$		$-40 \dots +150 (125)$	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	4000	V
humidity climate	DIN 40 040	Class F	
	DIN IEC 68 T.1	40/125/56	
Inverse Diode <sup>8)</sup>			
$I_F = -I_c$	$T_{case} = 25/80^\circ\text{C}$	230 / 150	A
$I_{FMS} = -I_{CM}$	$T_{case} = 25/80^\circ\text{C}; t_p = 1 \text{ ms}$	600 / 400	A
$I_{FSM}$	$t_p = 10 \text{ ms}; \sin.; T_j = 150^\circ\text{C}$	2200	A
$I^2t$	$t_p = 10 \text{ ms}; T_j = 150^\circ\text{C}$	24200	$\text{A}^2\text{s}$

## SEMITRANS® M IGBT Modules

### SKM 300 GA 173 D



SEMITRANS 4



GA

#### Features

- MOS input (voltage controlled)
- N channel, Homogeneous Si
- Low inductance case
- Very low tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 * I_{cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes<sup>8)</sup>
- Isolated copper baseplate using DCB Direct Copper Bonding
- Large clearance (13 mm) and creepage distances (20 mm).

#### Typical Applications:

- AC inverter drives on mains 575 - 750 V<sub>AC</sub>
- DC bus voltage 750 - 1200 V<sub>DC</sub>
- Public transport (auxiliary syst.)
- Switching (not for linear use)

<sup>1)</sup>  $T_{case} = 25^\circ\text{C}$ , unless otherwise specified

<sup>2)</sup>  $I_F = -I_c, V_R = 1200 \text{ V}, -di_F/dt = 1500 \text{ A}/\mu\text{s}, V_{GE} = 0 \text{ V}$

<sup>3)</sup> Use  $V_{GEoff} = -5 \dots -15 \text{ V}$

<sup>8)</sup> CAL = Controlled Axial Lifetime Technology.

Cases and mech. data → B6-268

Characteristics		min.	typ.	max.	Units
Symbol	Conditions <sup>1)</sup>				
$V_{(BR)CES}$	$V_{GE} = 0, I_c = 4 \text{ mA}$	$\geq V_{CES}$	—	—	V
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_c = 16 \text{ mA}$	4,8	5,5	6,2	V
$I_{CES}$	$\left. \begin{array}{l} V_{GE} = 0 \\ V_{CE} = V_{CES} \end{array} \right\} T_j = 25^\circ\text{C}$	—	—	4	mA
$I_{GES}$	$\left. \begin{array}{l} V_{GE} = 0 \\ V_{CE} = 125^\circ\text{C} \end{array} \right\} T_j = 125^\circ\text{C}$	—	—	12	mA
$V_{CEsat}$	$V_{GE} = 20 \text{ V}, V_{CE} = 0 \text{ V}$	—	—	400	nA
$V_{CEsat}$	$I_c = 200 \text{ A} \left\{ \begin{array}{l} V_{GE} = 15 \text{ V} \\ V_{CE} = 25 (125)^\circ\text{C} \end{array} \right\}$	—	3,4(4,5)	3,9(5)	V
$V_{CEsat}$	$I_c = 300 \text{ A}   T_j = 25 (125)^\circ\text{C}$	—	3,8(5,5)	—	V
$g_{fs}$	$V_{CE} = 20 \text{ V}, I_c = 200 \text{ A}$	—	—	—	S
$C_{CHC}$	per IGBT	—	—	400	pF
$C_{ies}$	$\left. \begin{array}{l} V_{GE} = 0 \\ V_{CE} = 25 \text{ V} \end{array} \right\} f = 1 \text{ MHz}$	—	32	—	nF
$C_{oes}$		—	2,5	—	nF
$C_{res}$		—	1	—	nF
$L_{CE}$		—	—	20	nH
$t_{d(on)}$	$\left. \begin{array}{l} V_{CC} = 1200 \text{ V} \\ V_{GE} = +15 \text{ V} / -15 \text{ V}^3 \end{array} \right\}$	—	410	—	ns
$t_r$		—	90	—	ns
$t_{d(off)}$	$I_c = 200 \text{ A}, \text{ind. load}$	—	750	—	ns
$t_f$	$R_{Gon} = R_{Goff} = 3 \Omega$	—	40	—	ns
$E_{on}$	$T_j = 125^\circ\text{C}$	—	110	—	mWs
$E_{off}$		—	60	—	mWs
Inverse Diode <sup>8)</sup>					
$V_F = V_{EC}$	$I_F = 200 \text{ A} \left\{ \begin{array}{l} V_{GE} = 0 \text{ V} \\ V_{CE} = 25 (125)^\circ\text{C} \end{array} \right\}$	—	2,2(1,9)	2,7	V
$V_F = V_{EC}$	$I_F = 300 \text{ A}   T_j = 25 (125)^\circ\text{C}$	—	2,4(2,2)	—	V
$V_{TO}$	$T_j = 125^\circ\text{C}$	—	1,3	1,5	V
$r_T$	$T_j = 125^\circ\text{C}$	—	4	4,5	$\text{m}\Omega$
$I_{RR}$	$I_F = 200 \text{ A}; T_j = 25 (125)^\circ\text{C}^2$	—	100(150)	—	A
$Q_{rr}$	$I_F = 200 \text{ A}; T_j = 25 (125)^\circ\text{C}^2$	—	24(58)	—	$\mu\text{C}$
Thermal Characteristics					
$R_{thjc}$	per IGBT	—	—	0,07	$^\circ\text{C}/\text{W}$
$R_{thjc}$	per diode D	—	—	0,21	$^\circ\text{C}/\text{W}$
$R_{thch}$	per module	—	—	0,038	$^\circ\text{C}/\text{W}$

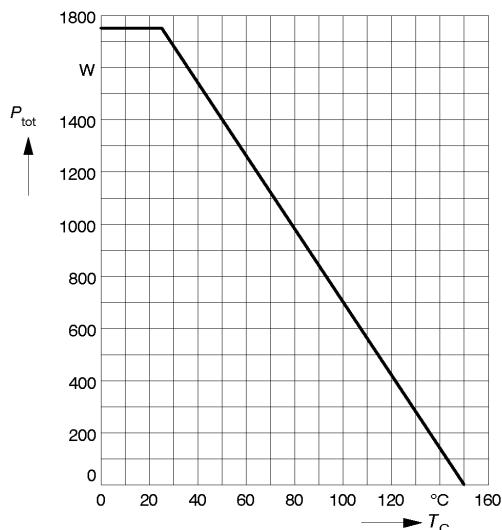


Fig. 1 Rated power dissipation  $P_{tot} = f(T_C)$

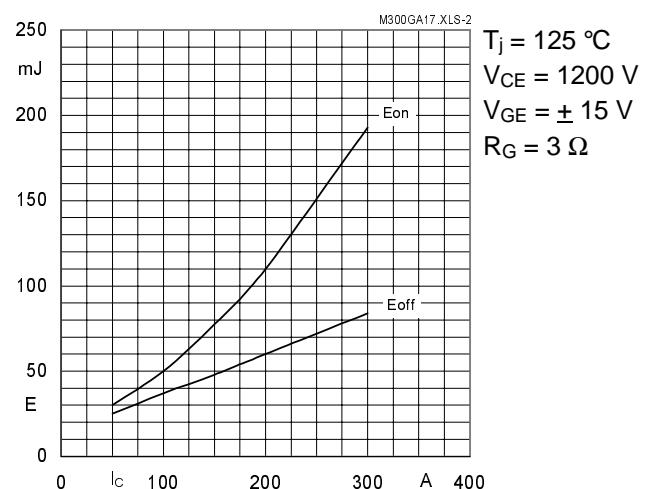


Fig. 2 Turn-on /-off energy =  $f(I_C)$

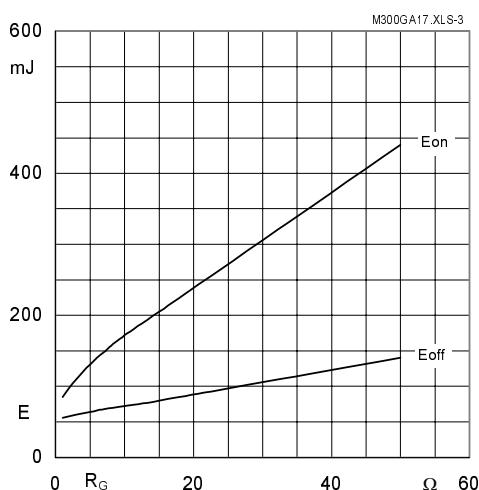


Fig. 3 Turn-on /-off energy =  $f(R_G)$

$T_j = 125^\circ\text{C}$   
 $V_{CE} = 1200\text{ V}$   
 $V_{GE} = \pm 15\text{ V}$   
 $I_C = 200\text{ A}$

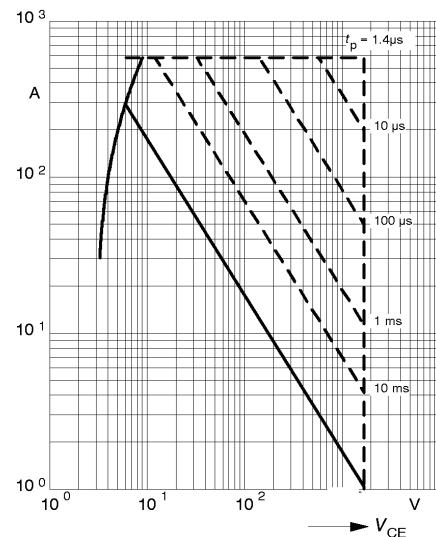


Fig. 4 Maximum safe operating area (SOA)  $I_C = f(V_{CE})$

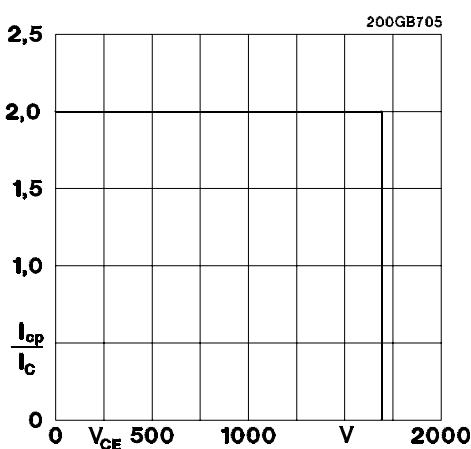


Fig. 5 Turn-off safe operating area (RBSOA)

$T_j \leq 150^\circ\text{C}$   
 $V_{GE} = 15\text{ V}$   
 $R_{Goff} = 3\Omega$   
 $I_C = 200\text{ A}$

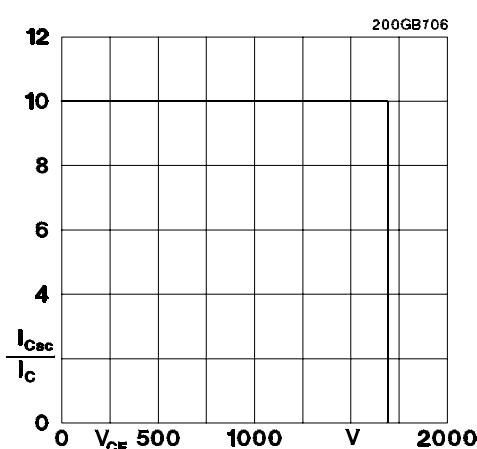


Fig. 6 Safe operating area at short circuit  $I_C = f(V_{CE})$

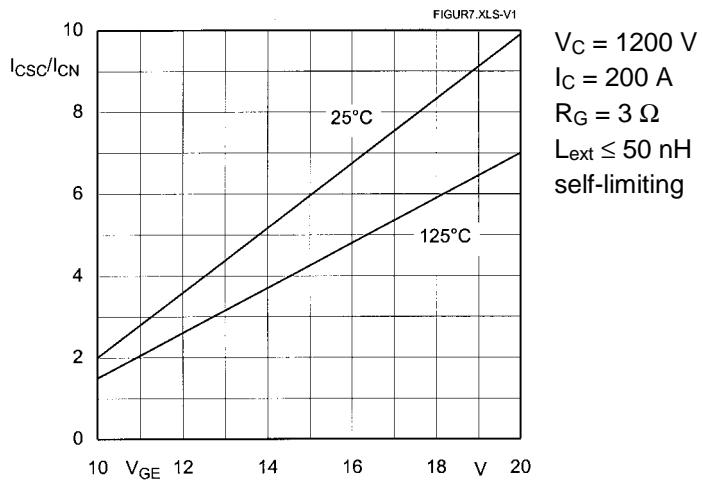


Fig. 7 Short circuit current vs. turn-on gate voltage

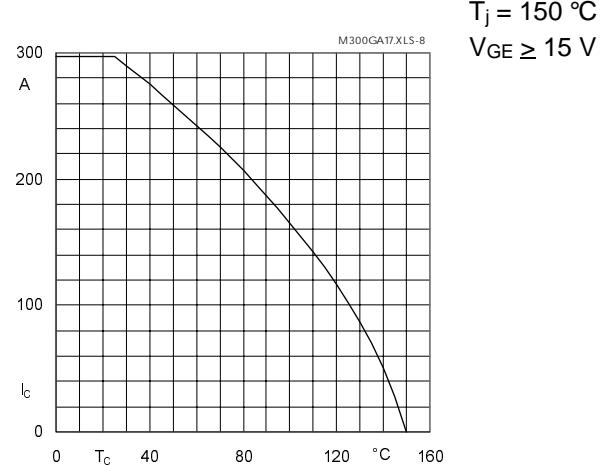


Fig. 8 Rated current vs. temperature  $I_C = f(T_j)$

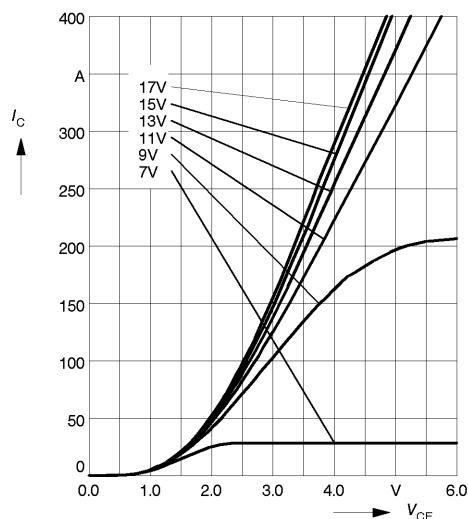


Fig. 9 Typ. output characteristic,  $t_p = 80 \mu s$ ;  $T_j = 25^\circ C$

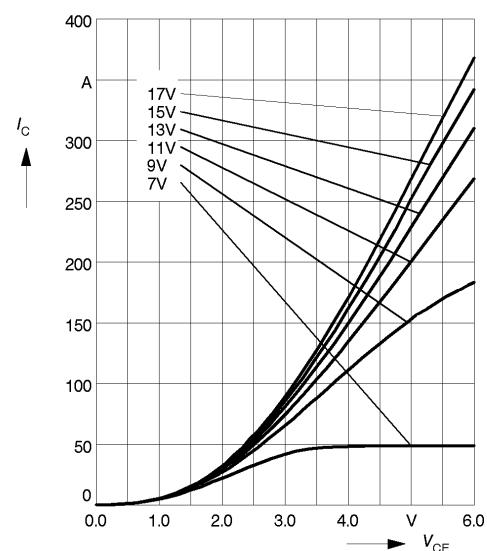


Fig. 10 Typ. output characteristic,  $t_p = 80 \mu s$ ;  $T_j = 125^\circ C$

$$P_{cond(t)} = V_{CEsat(t)} \cdot I_C(t)$$

$$V_{CEsat(t)} = V_{CE(TO)(Tj)} + r_{CE(Tj)} \cdot I_C(t)$$

$$V_{CE(TO)(Tj)} \leq 1.9 + 0.003 (T_j - 25) [\text{V}]$$

$$r_{CE(Tj)} = 0.0085 + 0.00003 (T_j - 25) [\Omega]$$

valid for  $V_{GE} \leq + 15^{+2}_{-1} [\text{V}]$ ;  $I_C \geq 0.3 I_{Cnom}$

Fig. 11 Typ. saturation characteristic (IGBT)  
Calculation elements and equations

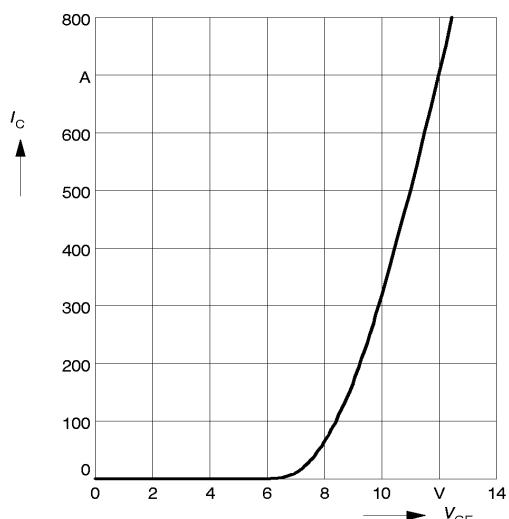


Fig. 12 Typ. transfer characteristic,  $t_p = 80 \mu s$ ;  $V_{CE} = 20 \text{ V}$

# SKM 300 GA 173 D

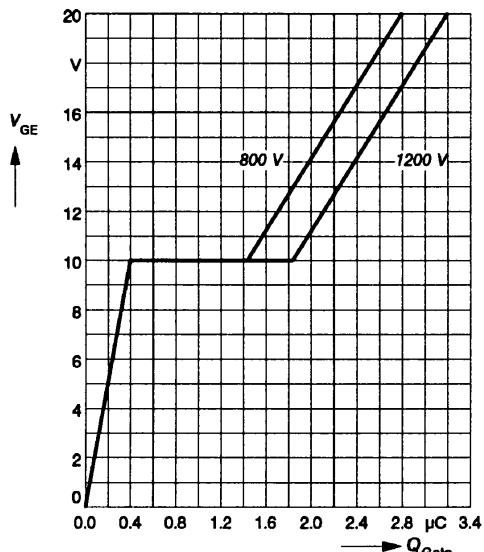


Fig. 13 Typ. gate charge characteristic

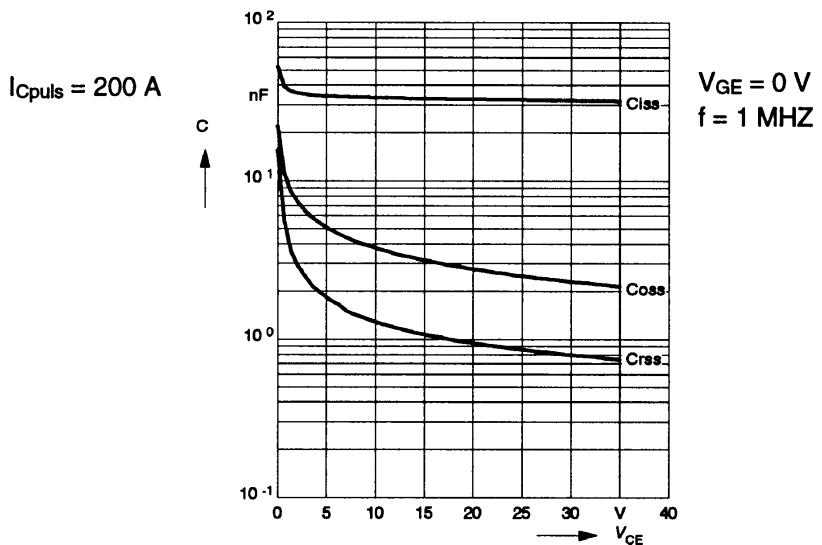


Fig. 14 Typ. capacitances vs. $V_{CE}$

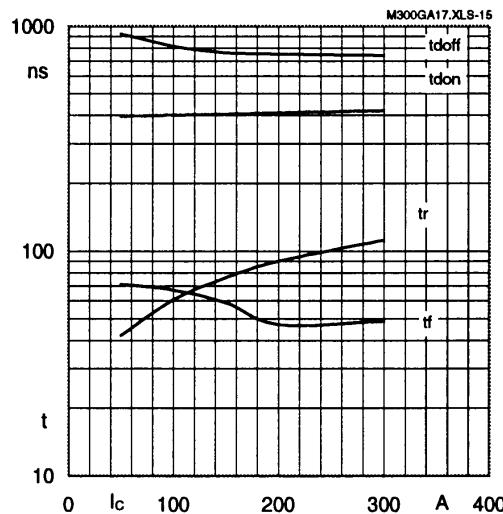


Fig. 15 Typ. switching times vs.  $I_C$

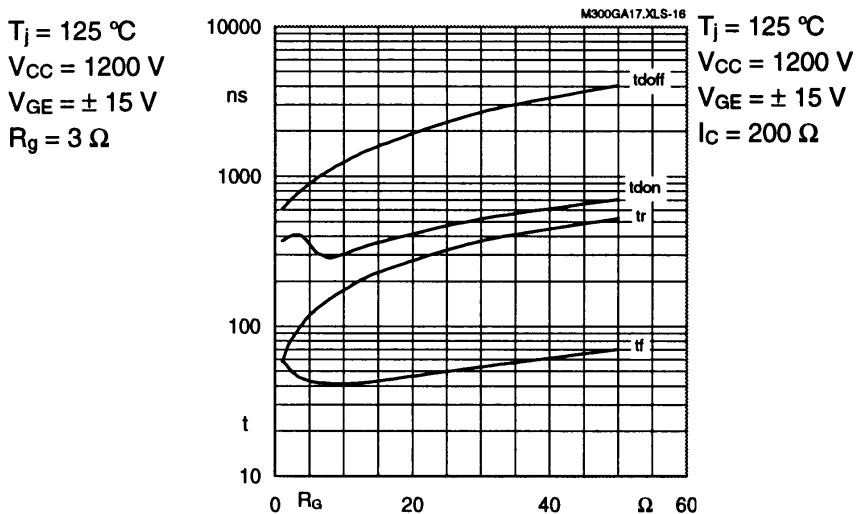


Fig. 16 Typ. switching times vs.  $R_G$

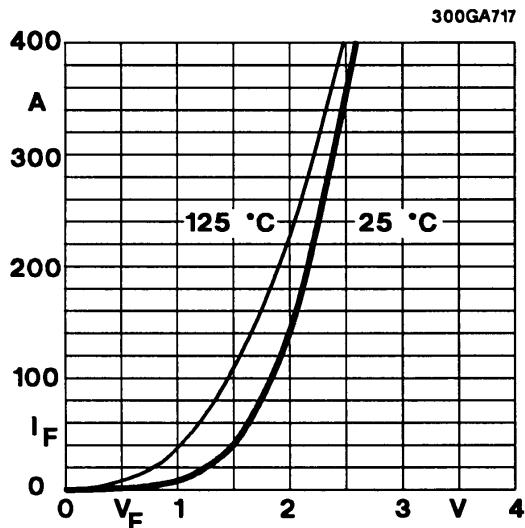


Fig. 17 Typ. CAL diode forward characteristic

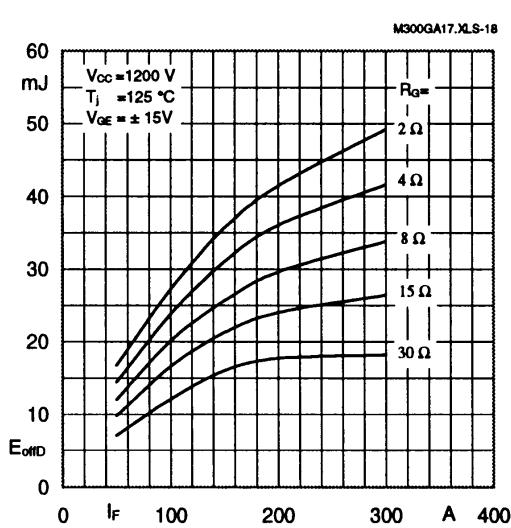


Fig. 18 Typ. Diode turn-off energy dissipation per pulse

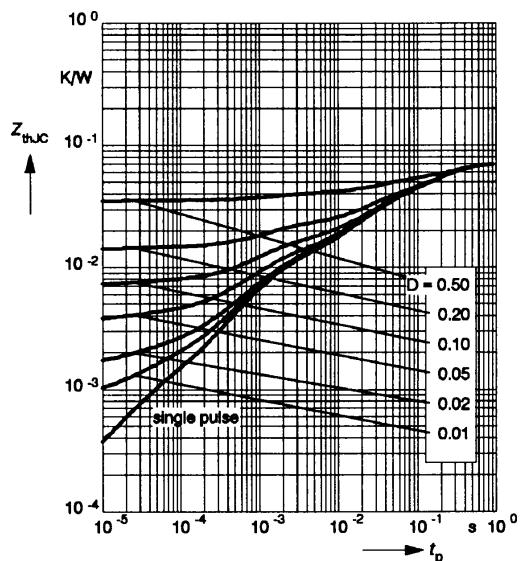


Fig. 19 Transient thermal impedance of IGBT:  $Z_{thjc} = f(t_p)$ ;  $D = t_p / t_c = t_p \cdot f$

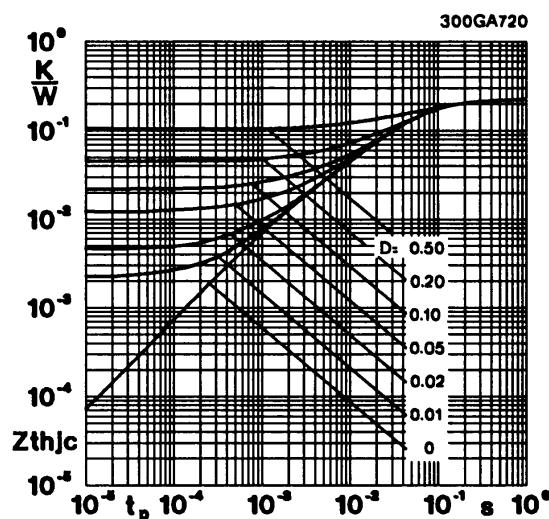


Fig. 20 Transient thermal impedance of inverse diode:  $Z_{thjcD} = f(t_p)$

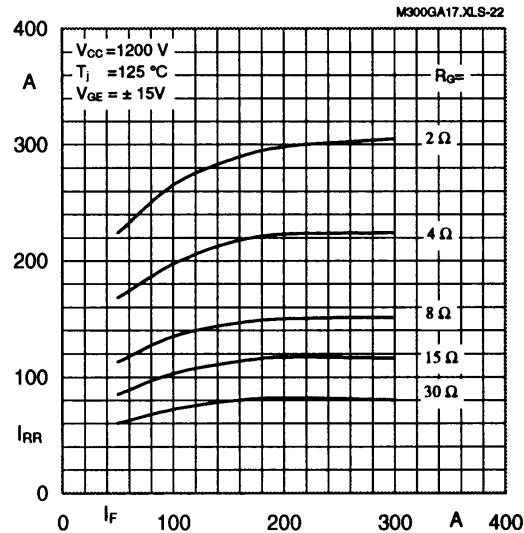


Fig. 22 Typ. CAL diode peak reverse recovery current of inverse diode  $I_{RR} = f(I_F; R_Q)$

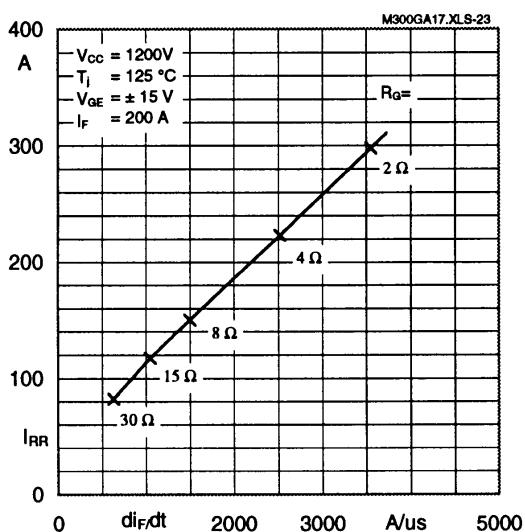


Fig. 23 Typ. CAL diode peak reverse recovery current of inverse diode:  $I_{RR} = f(di_F/dt)$

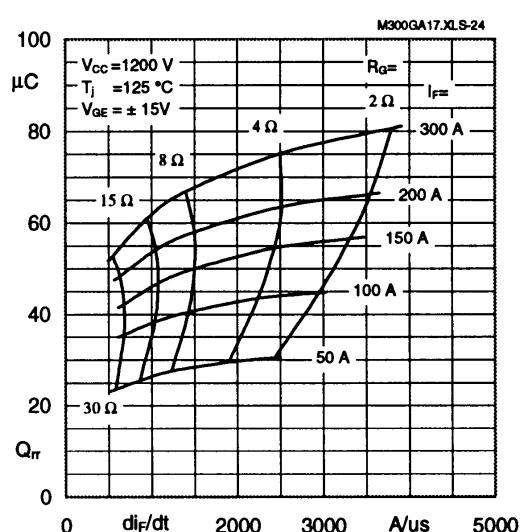


Fig. 24 Typ. CAL diode recovered charge  $Q_{rr}$  of inverse diode

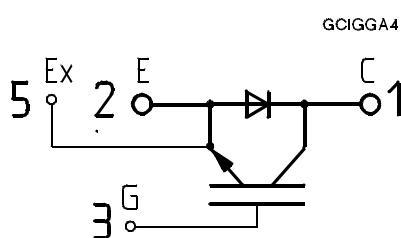
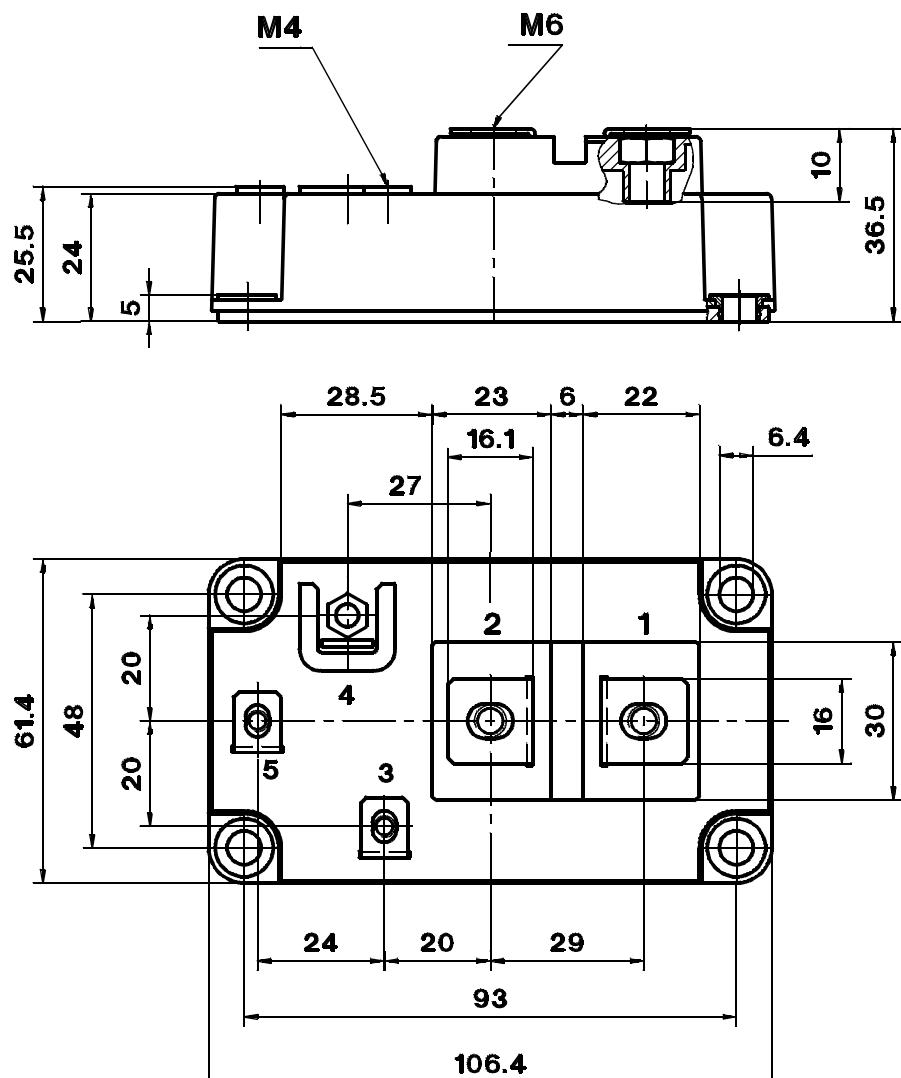
## SEMITRANS 4

Case D 59

UL Recognized

File no. E 63 532

CASED59



Dimensions in mm

Outline and circuit

Symbol	Conditions	Values			Units	
		min.	typ.	max.		
M <sub>1</sub>	to heatsink, SI Units	(M6)	3	—	5	Nm
	to heatsink, US Units		27	—	44	lb.in.
M <sub>2</sub>	for terminals, SI Units	(M6/M4)	2,5/1,1	—	5/2	Nm
	for terminals US Units		22/10	—	44/18	lb.in.
a			—	—	5x9,81	m/s <sup>2</sup>
w			—	—	330	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Three devices are supplied in one SEMIBOX B without mounting hardware, which can be ordered separately under Ident No. 33321100 (for 10 SEMITRANS 4). Larger packing units of 12 and 20 pieces are used if suitable. Accessories → B 6 - 4. SEMIBOX B → C - 2.